Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/797,786	OKANAKA ET AL.
Examiner	Art Unit
Christopher P. Schwartz	3683

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
1	DATE	EXMR		
Sevuli Adakel	1/13/04	P.		
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